

**Search Notes**

Application/Control No.

10/669,496

Examiner

Vuthe Siek

Applicant(s)/Patent under  
Reexamination

CHANG ET AL.

Art Unit

2825

**SEARCHED**

Class	Subclass	Date	Examiner
716	2-6,7-8	3/1/2805	VS

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST ALL DATABASES	3/28/2005	VS
EAST all databases See Search History Printout	10/22/05	VS